

Quad TTL to MECL Translator

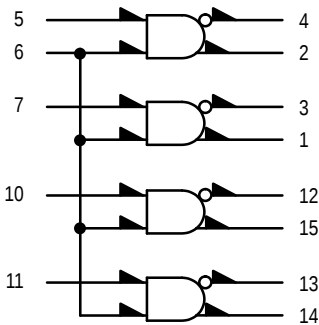
The MC10124 is a quad translator for interfacing data and control signals between a saturated logic section and the MECL section of digital systems. The MC10124 has TTL compatible inputs, and MECL complementary open-emitter outputs that allow use as an inverting/ non-inverting translator or as a differential line driver. When the common strobe input is at the low logic level, it forces all true outputs to a MECL low logic state and all inverting outputs to a MECL high logic state.

Power supply requirements are ground, +5.0 Volts, and -5.2 Volts. Propagation delay of the MC10124 is typically 3.5 ns. The dc levels are standard or Schottky TTL in, MECL 10,000 out.

An advantage of this device is that TTL level information can be transmitted differentially, via balanced twisted pair lines, to the MECL equipment, where the signal can be received by the MC10115 or MC10116 differential line receivers. The MC10124 is useful in computers, instrumentation, peripheral controllers, test equipment, and digital communications systems.

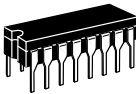
$P_D = 380 \text{ mW typ/pkg (No Load)}$
 $t_{pd} = 3.5 \text{ ns typ (+ 1.5 Vdc in to 50% out)}$
 $t_r, t_f = 2.5 \text{ ns typ (20\%–80\%)}$

LOGIC DIAGRAM

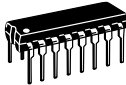


Gnd = PIN 16
V_{CC} (+5.0Vdc) = PIN 9
V_{EE} (-5.2Vdc) = PIN 8

MC10124



L SUFFIX
CERAMIC PACKAGE
CASE 620-10

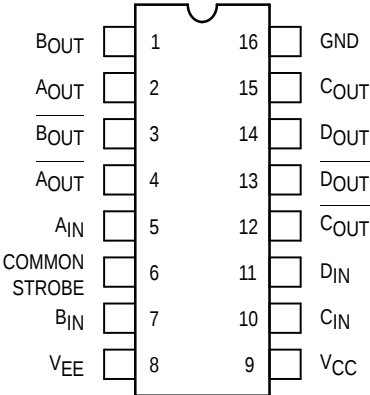


P SUFFIX
PLASTIC PACKAGE
CASE 648-08



FN SUFFIX
PLCC
CASE 775-02

DIP
PIN ASSIGNMENT



Pin assignment is for Dual-in-Line Package.
For PLCC pin assignment, see the Pin Conversion
Tables on page 6-11 of the Motorola MECL Data
Book (DL122/D).



ELECTRICAL CHARACTERISTICS

Characteristic	Symbol	Pin Under Test	Test Limits							Unit
			−30°C		+25°C			+85°C		
			Min	Max	Min	Typ	Max	Min	Max	
Negative Power Supply Drain Current	I _E	8		72			66		72	mAdc
Positive Power Supply Drain Current	I _{CCH}	9		16			16		18	mAdc
	I _{CCL}	9		25			25		25	mAdc
Reverse Current	I _R	6 7		200 50			200 50		200 50	μAdc
Forward Current	I _F	6 7		−12.8 −3.2			−12.8 −3.2		−12.8 −3.2	mAdc
Input Breakdown Voltage	BV _{in}	6 7	5.5 5.5		5.5 5.5			5.5 5.5		Vdc
Clamp Input Voltage	V _I	6 7		−1.5 −1.5			−1.5 −1.5		−1.5 −1.5	Vdc
High Output Voltage	V _{OH}	1 3	−1.060 −1.060	−0.890 −0.890	−0.960 −0.960		−0.810 −0.810	−0.890 −0.890	−0.700 −0.700	Vdc
Low Output Voltage	V _{OL}	1 3	−1.890 −1.890	−1.675 −1.675	−1.850 −1.850		−1.650 −1.650	−1.825 −1.825	−1.615 −1.615	Vdc
High Threshold Voltage	V _{OHA}	1 3	−1.080 −1.080		−0.980 −0.980			−0.910 −0.910		Vdc
Low Threshold Voltage	V _{OLA}	1 3		−1.655 −1.655			−1.630 −1.630		−1.595 −1.595	Vdc
Switching Times (50Ω Load)										ns
Propagation Delay (+3.5Vdc to 50%) ¹	t ₆₊₁₊	1	1.5	6.8	1.0	3.5	6.0	1.0	6.0	
	t _{6−1−}	1	1.0	6.0	1.0	3.5	6.0	1.5	6.8	
	t ₇₊₁₊	1	1.5	6.8	1.0	3.5	6.0	1.0	6.0	
	t _{7−1−}	1	1.0	6.0	1.0	3.5	6.0	1.5	6.8	
	t _{7+3−}	3	1.5	6.8	1.0	3.5	6.0	1.0	6.0	
	t _{7−3+}	3	1.0	6.0	1.0	3.5	6.0	1.5	6.8	
Rise Time (20 to 80%)	t ₁₊	1	1.0	4.2	1.1	2.5	3.9	1.1	4.3	
Fall Time (20 to 80%)	t _{1−}	1	1.0	4.2	1.1	2.5	3.9	1.1	4.3	

1. See switching time test circuit. Propagation delay for this circuit is specified from +1.5Vdc in to the 50% point on the output waveform. The +3.5Vdc is shown here because all logic and supply levels are shifted 2 volts positive.

ELECTRICAL CHARACTERISTICS (continued)

@ Test Temperature			TEST VOLTAGE VALUES (Volts)					Gnd
			V _{IH}	V _{ILmax}	V _{IHA'}	V _{ILA'}	V _F	
			−30°C	+4.0	+0.40	+2.00	+1.10	+0.40
			+25°C	+4.0	+0.40	+1.80	+1.10	+0.40
			+85°C	+4.0	+0.40	+1.80	+0.90	+0.40
Characteristic	Symbol	Pin Under Test	TEST VOLTAGE APPLIED TO PINS LISTED BELOW					Gnd
			V _{IH}	V _{ILmax}	V _{IHA'}	V _{ILA'}	V _F	
Negative Power Supply Drain Current	I _E	8						16
Positive Power Supply Drain Current	I _{CCH}	9	5,6,7,10,11					16
	I _{CCL}	9						5,6,7,10,11,16
Reverse Current	I _R	6					5,7,10,11	16
		7					6	16
Forward Current	I _F	6	5,7,10,11				6	16
		7	6				7	16
Input Breakdown Voltage	BV _{in}	6						5,7,10,11,16
		7						6,16
Clamp Input Voltage	V _I	6						16
		7						16
High Output Voltage	V _{OH}	1	6,7					16
		3		6,7				16
Low Output Voltage	V _{OL}	1		6,7				16
		3	6,7					16
High Threshold Voltage	V _{OHA}	1	6		7			16
		3	6			7		16
Low Threshold Voltage	V _{OLA}	1	6			7		16
		3	6		7			16
Switching Times (50Ω Load)			+6.0 V	Pulse In	Pulse Out			+2.0 V
Propagation Delay (+3.5Vdc to 50%) ¹	t ₆₊₁₊	1	7	6	1			16
	t _{6−1−}	1	7	6	1			16
	t ₇₊₁₊	1	6	7	1			16
	t _{7−1−}	1	6	7	1			16
	t _{7+3−}	3	6	7	3			16
	t _{7−3+}	3	6	7	3			16
Rise Time (20 to 80%)	t ₁₊	1	6	7	1			16
Fall Time (20 to 80%)	t _{1−}	1	6	7	1			16

1. See switching time test circuit. Propagation delay for this circuit is specified from +1.5Vdc in to the 50% point on the output waveform. The +3.5Vdc is shown here because all logic and supply levels are shifted 2 volts positive.

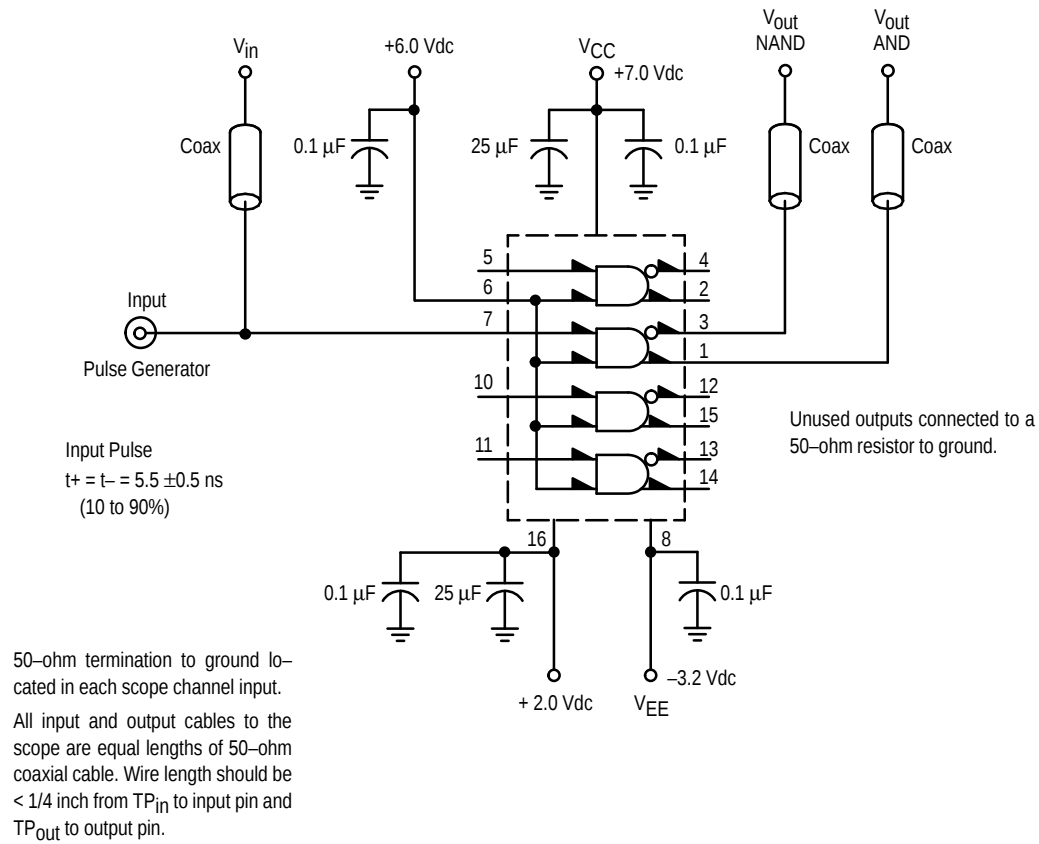
ELECTRICAL CHARACTERISTICS (continued)

@ Test Temperature			TEST VOLTAGE VALUES (Volts)			(mA)		Gnd
			V_R	V_{CC}	V_{EE}	I_I	I_{in}	
			−30°C	+2.40	+5.00	−5.2	−10	+1.0
			+25°C	+2.40	+5.00	−5.2	−10	+1.0
			+85°C	+2.40	+5.00	−5.2	−10	+1.0
Characteristic	Symbol	Pin Under Test	TEST VOLTAGE APPLIED TO PINS LISTED BELOW					Gnd
			V_R	V_{CC}	V_{EE}	I_I	I_{in}	
Negative Power Supply Drain Current	I_E	8		9	8			16
Positive Power Supply Drain Current	I_{CCH}	9		9	8			16
	I_{CCL}	9		9	8			5,6,7,10,11,16
Reverse Current	I_R	6	6	9	8			16
		7	7	9	8			16
Forward Current	I_F	6		9	8			16
		7		9	8			16
Input Breakdown Voltage	BV_{in}	6		9	8		6	5,7,10,11,16
		7		9	8		7	6,16
Clamp Input Voltage	V_I	6		9	8	6		16
		7		9	8	7		16
High Output Voltage	V_{OH}	1		9	8			16
		3		9	8			16
Low Output Voltage	V_{OL}	1		9	8			16
		3		9	8			16
High Threshold Voltage	V_{OHA}	1		9	8			16
		3		9	8			16
Low Threshold Voltage	V_{OLA}	1		9	8			16
		3		9	8			16
Switching Times (50Ω Load)				+7.0 V	−3.2 V			+2.0 V
Propagation Delay (+3.5Vdc to 50%) ¹	t_{6+1+}	1		9	8			16
	t_{6-1-}	1		9	8			16
	t_{7+1+}	1		9	8			16
	t_{7-1-}	1		9	8			16
	t_{7+3-}	3		9	8			16
	t_{7-3+}	3		9	8			16
Rise Time (20 to 80%)	t_{1+}	1		9	8			16
Fall Time (20 to 80%)	t_{1-}	1		9	8			16

1. See switching time test circuit. Propagation delay for this circuit is specified from +1.5Vdc in to the 50% point on the output waveform. The +3.5Vdc is shown here because all logic and supply levels are shifted 2 volts positive.

Each MECL 10,000 series circuit has been designed to meet the dc specifications shown in the test table, after thermal equilibrium has been established. The circuit is in a test socket or mounted on a printed circuit board and transverse air flow greater than 500 linear fpm is maintained. Outputs are terminated through a 50-ohm resistor to −2.0 volts. Test procedures are shown for only one gate. The other gates are tested in the same manner.

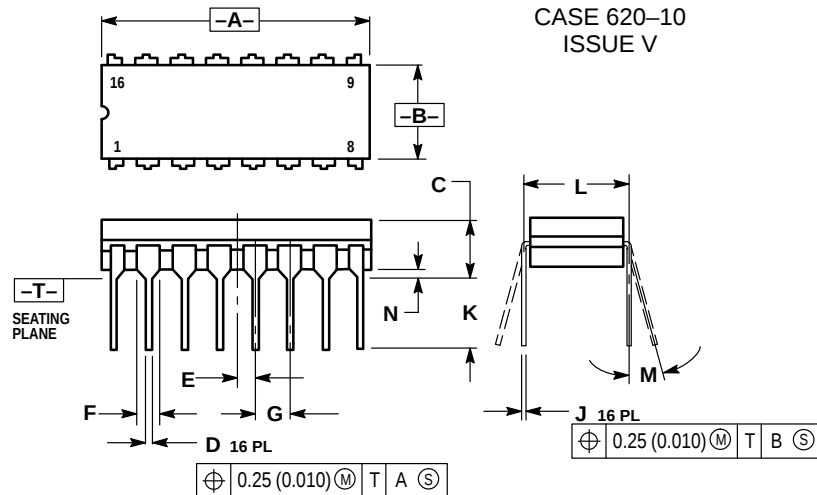
SWITCHING TIME TEST CIRCUIT



NOTE: All power supply and logic levels are shown shifted 2 volts positive.

OUTLINE DIMENSIONS

L SUFFIX
CERAMIC DIP PACKAGE
CASE 620-10
ISSUE V

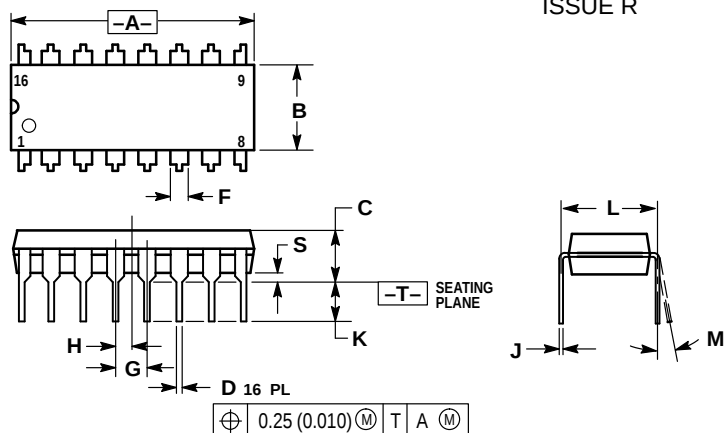


NOTES:

1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: INCH.
3. DIMENSION L TO CENTER OF LEAD WHEN FORMED PARALLEL.
4. DIMENSION F MAY NARROW TO 0.76 (0.030) WHERE THE LEAD ENTERS THE CERAMIC BODY.

DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	0.750	0.785	19.05	19.93
B	0.240	0.295	6.10	7.49
C	—	0.200	—	5.08
D	0.015	0.020	0.39	0.50
E	0.050	BSC	1.27	BSC
F	0.055	0.065	1.40	1.65
G	0.100	BSC	2.54	BSC
H	0.008	0.015	0.21	0.38
K	0.125	0.170	3.18	4.31
L	0.300	BSC	7.62	BSC
M	0°	15°	0°	15°
N	0.020	0.040	0.51	1.01

P SUFFIX
PLASTIC DIP PACKAGE
CASE 648-08
ISSUE R



NOTES:

1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: INCH.
3. DIMENSION L TO CENTER OF LEADS WHEN FORMED PARALLEL.
4. DIMENSION B DOES NOT INCLUDE MOLD FLASH.
5. ROUNDED CORNERS OPTIONAL.

DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	0.740	0.770	18.80	19.55
B	0.250	0.270	6.35	6.85
C	0.145	0.175	3.69	4.44
D	0.015	0.021	0.39	0.53
F	0.040	0.70	1.02	1.77
G	0.100	BSC	2.54	BSC
H	0.050	BSC	1.27	BSC
J	0.008	0.015	0.21	0.38
K	0.110	0.130	2.80	3.30
L	0.295	0.305	7.50	7.74
M	0°	10°	0°	10°
S	0.020	0.040	0.51	1.01

Motorola reserves the right to make changes without further notice to any products herein. Motorola makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does Motorola assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation consequential or incidental damages. "Typical" parameters which may be provided in Motorola data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. Motorola does not convey any license under its patent rights nor the rights of others. Motorola products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or other applications intended to support or sustain life, or for any other application in which the failure of the Motorola product could create a situation where personal injury or death may occur. Should Buyer purchase or use Motorola products for any such unintended or unauthorized application, Buyer shall indemnify and hold Motorola and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that Motorola was negligent regarding the design or manufacture of the part. Motorola and  are registered trademarks of Motorola, Inc. Motorola, Inc. is an Equal Opportunity/Affirmative Action Employer.

How to reach us:

USA/EUROPE/Locations Not Listed: Motorola Literature Distribution;
P.O. Box 5405, Denver, Colorado 80217. 303-675-2140 or 1-800-441-2447

Mfax™: RMFAX0@email.sps.mot.com – TOUCHTONE 602-244-6609
INTERNET: http://Design-NET.com

JAPAN: Nippon Motorola Ltd.; Tatsumi-SPD-JLDC, 6F Seibu-Butsuryu-Center,
3-14-2 Tatsumi Koto-Ku, Tokyo 135, Japan. 81-3-3521-8315

ASIA/PACIFIC: Motorola Semiconductors H.K. Ltd.; 8B Tai Ping Industrial Park,
51 Ting Kok Road, Tai Po, N.T., Hong Kong. 852-26629298

